Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10634125	OKAZAKI ET AL.
Examiner	Art Unit
Sabiha Qazi	1628

SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES		
Search Notes	Date	Examiner
STN DATABASE SEARCH, REGISTRY, HCAPLUS, MEDLINE, BIOSIS, EMBASE, WPIX, JAPIO, PASCAL AND OTHERS.	6/4/10	STIC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/Sabiha Qazi/ Primary Examiner.Art Unit 1628

U.S. Patent and Trademark Office Part of Paper No.: 20100927